Applicant(s)/Patent Under Application/Control No. Reexamination 10/627,780 FAN, KEJUN Notice of References Cited Examiner Art Unit Page 1 of 1 1637 Young J. Kim **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 435/270 US-6,342,387 01-2002 Hayashizaki et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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